

US PATENT DOCUMENTS							
Examiner USP Document Publication Date Initial Number		Name of Patentee or Applicant of cited Document	Class Subclass		Filing Date If Appropriate		
m	US-4775973	10/04/1988	Tomberlin, J., et al	370	60	10/22/1986	

FOREIGN PATENT DOCUMENTS								
Examiner Initials*	Foreign Document No	Publication Date	Name of Patentee or Applicant of cited Document	Class	Subclass	T ²		

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Substitute for form 1449A/PTO Complete if Known INFORMATION DISCLOSURE **Application Number** 10/039220 STATEMENT BY APPLICANT January 4, 2002 **Filing Date First Named Inventor** Ko, Yiu Fai **Group Art Unit** Unknown **Examiner Name** Unknown Attorney Docket No: 01365.060US1 Sheet 1 of 1

	US PATENT DOCUMENTS								
Examiner Initial *			Name of Patentee or Applicant of cited Document	Class	Subclass	Filing Date If Appropriate			
po	US-6266514	07/24/2001	O'Donnell, O	455	67.3	11/06/1998			

FOREIGN PATENT DOCUMENTS								
Examiner Initials*	Foreign Document No	Publication Date	Name of Patentee or Applicant of cited Document	Class	Subcla ss	T²		
re	WO-00/28755	05/18/2000	O'Donnell, O	H04Q	7/34			
N	WO-00/28756	05/18/2000	Hogan, B	H04Q	7/34			
m	WO-99/12228	03/11/1999	Watson, J R, et al	H01Q				

OTHER DOCUMENTS NON PATENT LITERATURE DOCUMENTS					
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